


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,107	TSENG ET AL.	
	Examiner	Art Unit	
	Than Nguyen	2187	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
711	5,154	6/12/2006	NTV
714	34,35	6/12/2006	NTV

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
West IEEE Inventor search	6/12/2006	NTV